Tektronix®

6 시리즈 로우 프로파일 디지타이저

LPD64 데이터 시트

고성능 디지타이저. 모든 채널에서!

4 channels with 25 GS/s, 12-bits, 8 GHz, and 250 Mpts in 2U





수치로 보는 제품 성능

Input Channels

- 4 SMA inputs
- Each SMA input supports Analog, Spectral (using DDC), or both simultaneously

Performance for EVERY Channel

- Sample Rate: 25 GS/s
- Bandwidth: DC to 8 GHz (optional)
- Vertical Resolution: 12-bit ADC
- · Real-Time 2 GHz DDC (optional)
- Record Length: 125 Mpts (std), 250 Mpts (optional)
- Lowest-in-class Noise
- Highest-in-class ENOB
- Best-in-class channel-to-channel isolation

Real-Time Digital Down Converter (DDC)

- Patented individual time domain and frequency domain controls
- Up to 2 GHz capture bandwidth (optional)
- IQ data transfers to PC for analysis (optional)
- Frequency vs time, Phase vs time and Magnitude vs time plotting (optional)

Superior low noise, vertical resolution and accuracy

- Low input noise enabled by new TEK061 front-end ASICs
- Noise at 1mV/div: 54.8 uV @ 1 GHz
- Input Range: 10mV to 10 V full scale
- DC Gain Accuracy: +/-1.0% at all gain settings >1 mV/div
- Effective Number of Bits (ENOB):
 - 8.2 bits at 1 GHz
 - 7.6 bits at 2.5 GHz
 - o 7.25 bits at 4 GHz
 - 6.8 bits at 6 GHz
 - 6.5 bits at 8 GHz

Remote communication and connectivity

- Ethernet 10/100/1000 port
- USB 3.0 device port (USBTMC) up to 800 Megabits/second
- LXI 1.5 Certified (VXI-11)
- Easy remote access with e*Scope; just enter the instrument IP address into a browser
- Award-winning user interface

- Drivers: IVI-C, IVI-COM, LabVIEW
- Support for VISA, MATLAB, Python, C/C++/C#, Sockets

Measurement Analysis

- 36 standard measurements
- Jitter Measurements (optional)
- DDR Measurements (optional)
- Power Measurements (optional)

Operating Systems

- Closed Linux Embedded OS (standard)
- Microsoft Windows 10 (option 6-WINM2)

Security & Declassification (option 6-SEC)

- Password protect all user-accessible ports
- Locks down the digitizer, prevents on-instrument user data storage
- · Meets the needs for top secret and high security environments

Dimensions

- 2U (3.5 in./89 mm) tall & rack ready out of the box (standard configuration)
- 17 in. (432 mm) wide
- Fits into standard 24 32 in. (610 813 mm) racks
- · Air flow is left to right for rack setup



6 시리즈 로우 프로파일 디지타이저 LPD64는 입력 잡음이 가장 낮고 최대 8GHz 아날로그 대역폭으로 컴팩트 한 2U 랙 공간에서 신호를 분석하고 디버깅하기 위한 최상의 신호 충실도를 제공합니다. 6 시리 즈 로우 프로파일 디지타이저 LPD64는 아날로그, 스펙트럼 (DDC 사 용) 또는 동급 최하위 소음 및 동급 최고 ENOB를 모두 지원하는 4 개 의 SMA 입력을 통해 오늘날 가장 어려운 과제와 미래에도 대비할 수 있습니다.

6 시리즈 제품군

LPD64 (6 Series Low Profile Digitizer)는 동급의 모든 채널에서 최고 성능의 디지타이저를 나타냅니다. 이 고속 디지타이저는 디지타이저의 기능과 오실로스코프의 기능을 갖추고 있어 6 시리즈 MSO와 유사한 하드웨어 플랫폼을 공유합니다.

6 시리즈 MSO 벤치 탑 오실로스코프에서 로우 프로파일 디지타이저로의 전환은 R & D 엔지니어가 코드, 테스트 작업 및 플랫폼 성능을 제조 및 자동화로 이전해야 하는 경우에 결코 쉬운 일이 아닙니다. 두제품 모두 동일한 사용자 인터페이스, 원격 기능, 성능 특성 및 프로그래밍 백엔드를 지원하여 이러한 전환을 가능한 간단하고 쉽게 만듭니다. 테스트 루틴과 개발 테스트 사이클 코드를 다시 작성할 필요가 없습니다!

수상 경력에 빛나는 사용자 경험 및 다양한 분석 소프트웨어 옵션을 포함하여 벤치 탑 6 시리즈 MSO의 기능에 대한 자세한 내용은 www.tek.com/6SeriesMSO의 6시리즈 MSO 데이터 시트를 참조 하십시오.



로우 프로파일 제품군

6 시리즈 로우 프로파일 디지타이저는 동일한 2U 풋 프린트에 Tektronix TEK049 ASICS 수의 두 배를 추가하여 5 시리즈 MSO로우 프로파일의 성능을 확장합니다. 이제 모든 채널에서 25GS / s 및 최대 8GHz를 지원합니다. 로우 프로파일 사용자는 이제 동일한 랙 폼 팩터에서 매우 높은 채널 수 또는 최고의 성능을 선택할 수 있습니다.

5 시리즈 MSO 로우 프로파일 (8 채널, 1 GHz)의 기능에 대한 자세한 내용은 https://www.tek.com/ MSO58LP /의 데이터 시트를참조하십시오.





2 개의 6 시리즈 로우 프로파일 디지타이저 (왼쪽) 및 2 개의 5 시리즈 MSO 로우 프로파일 오실로스코프 (오른쪽)

Quick Comparison	6 Series Low Profile Digitizer	5 Series MSO Low Profile
Sample Rate	25 GS/s	6.25 GS/s
Analog Bandwidth	Up to 8 GHz	1 GHz
RF (DDC) Span Bandwidth	2 GHz	500 MHz
ENOB @ 1 GHz	8.2 bits	7.6 bits
LXI compliance version	1.5	-
Rack Dimensions	2U	2U

물리학을 위한 기계 진단

물리학은 끊임없이 물질과 에너지 모두에서 흥미로운 새로운 과학적 발견으로 세계를 이끌고 있습니다. 이러한 실험에는 대상 테스트 지 점을 모니터링 할 때 정밀도, 정확도, 성능 및 밀도가 개선 된 디지타 이저 및 오실로스코프가 필요합니다. 6 시리즈 로우 프로파일 디지 타이저는 업계 최고의 성능, 소형 폼 팩터, 텍트로닉스의 신뢰성 등 급, 간편한 원격 액세스 기능 및 수상 경력에 빛나는 사용자 인터페이 스를 제공하여 이러한 요구 사항을 충족합니다.



일반적인 물리학 분야

- 고에너지(입자)
- 물리 핵 물리
- 원자, 분자 및 광학 물리학
- 응축 문제

연구실에서 싱글 샷 이벤트 또는 빠른 반복 모니터링이 필요한 연구 분야; PDV (Photo Doppler Velocimetry), VISAR, 가스 건, 분광 법, 가속기 등의 실험. 이들 중 다수는 실험을 진단하고 도플러 편이, 위상 정렬, 비트 주파수, 빔 스티어링 정렬 또는 진폭을 검증합니다. 안정적인 고성능 장비로 이를 수행하는 것이 장기적인 성공의 열쇠 입니다.



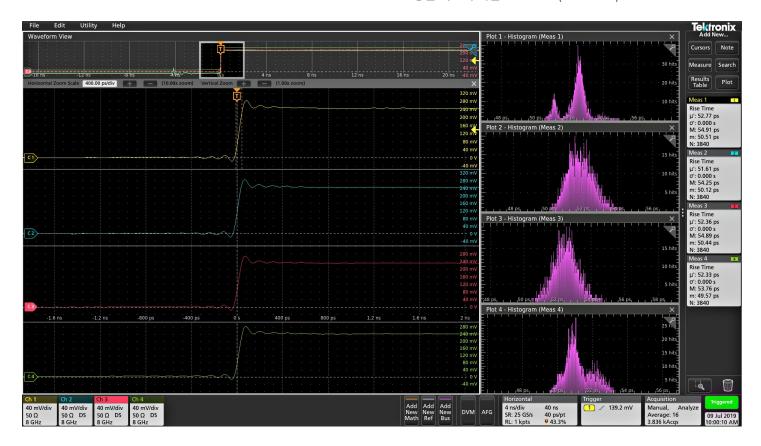
모든 채널에서의 성능

여러 디지타이저 채널을 켜고 샘플 속도, 레코드 길이 또는 대역 폭 설정이 무엇인지 궁금하십니까? 6 시리즈 로우 프로파일 디지 타이저는 항상 모든 채널에서 업계 최고의 성능을 제공합니다. 타 협하지 마십시오!

주요 성능 특징:

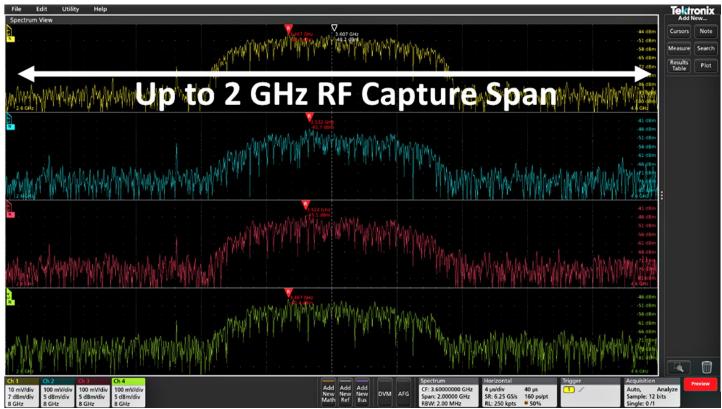
- 모든 채널에서 25 GS/s
- 모든 채널에서 DC ~ 8 GHz

- 모든 채널에서 최대 2억 5천만 샘플
- 모든 채널에서 최대 2 GHz RF DDC 캡처 대역폭
- 모든 채널은 2U 랙 지원 디지타이저에 잘 맞춤
- 12 비트 아날로그-디지털 변환기
- 동급 최고의 저소음
- 동급 최고의 유효 비트 수
- 동급 최고의 채널 isolation (crosstalk)





Spectrum View



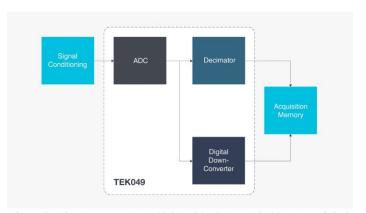
시간 도메인 제어와 무관한 중심 주파수, 스팬 및 해상도 대역푝(RBW)과 같은 직관적인 스펙트럼 분석기 제어는 주파수 도메인 분석을 위한 쉬운 설정을 제공합니다. 각 아날로그 입력에 대해 스펙트런보기를 사용할 수 있으므로 다중 채널 혼합 도메인 분석이 가능합니다.

주파수 영역에서 하나 이상의 신호를 보면 문제를 디버깅하기가 더 쉽습니다. 오실로스코프와 디지타이저에는 이러한 요구를 해결하기 위해 수십 년 동안 수학 기반 FFT가 포함되어 있습니다. 그러나 FFT는 아날로그 시간 영역보기를 제공하는 동일한 수집 시스템으로 구동되므로 사용하기가 매우 어렵다. 아날로그 보기에 대한 획득 설정을 최적화하면 주파수 영역보기가 원하는 것이 아닙니다. 원하는 주파수 영역보기를 얻을 때 아날로그 보기는 원하는 것이 아닙니다. 수학 기반 FFT를 사용하면 두 도메인 모두에서 최적화 된 뷰를 얻는 것이 사실상 불가능합니다.

스펙트럼 뷰는이 모든 것을 변경합니다. 텍트로닉스의 특허 기술은 시간 영역을위한 데시메이터 (decimator)와 각 입력 뒤에 주파수 영역을 위한 디지털 다운 컨버터를 제공합니다. 두 개의 서로 다른 획 득 경로를 사용하면 각 도메인에 대해 독립적인 획득 설정으로 입력 신호의 시간 및 주파수 도메인보기를 동시에 관찰 할 수 있습니다. 다 른 제조업체는 사용 편의성을 주장하는 다양한 '스펙트럼 분석'패키 지를 제공하지만 모두 위에서 설명한 제한을 나타냅니다.

Spectrum View만이 탁월한 사용 편의성과 두 도메인에서 동시에 최적의 뷰를 달성 할 수 있는 기능을 제공합니다.

모든 Tektronix 5 시리즈 및 6 시리즈 제품에 표준으로 제공되는 다양한 프로그래밍 명령 및 API 인터페이스를 사용하여 6 시리즈 로우 프로파일에서 PC로 파형 및 IQ 데이터를 쉽게 전송할 수 있습니다.

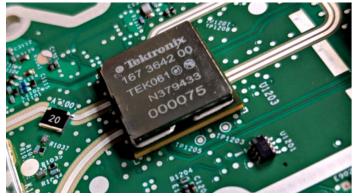


텍트로닉스의 TEK049 ASIC는 특허받은 신호 경로를 통해 신호를 ADC에서 전 통적인 데시 메이터 (scope)와 디지털 다운 컨버터 (DDC-RF)로 이동시켜 시간 및 주파수 영역을 독립적으로 제어 할 수 있습니다.



성능 뒤에

텍트로닉스에서 설계한 TEK049 ASIC에는 기존 8 비트 ADC보다 16 배 더 높은 해상도를 제공하는 12 비트 아날로그 디지털 컨버터 (ADC)가 포함되어 있습니다. TEK049는 업계 최고의 저잡음을 갖춘 새로운 Tektronix TEK061 프런트 엔드 증폭기와 함께 사용되어 작은 신호를 고해상도로 캡처 할 수 있는 최상의 신호 충실도를 제공합니다.



새로운 프런트 엔드 증폭기로 구현되는 최저 소음

작은 고속 신호에서 미세한 신호 세부 사항을 볼 수 있는 핵심 특성은 노이즈 입니다. 측정 시스템의 고유 노이즈가 높을수록 실제 신호 디테일이 덜 보입니다. 이는 고속 버스 토폴로지에서 널리 발생하는 작은 신호를 보기 위해 수직 설정을 높은 감도 (예 : \leq 10 mV/div)로 설정하면 디지타이저에서 더욱 중요합니다. 6 시리즈 로우 프로파일에는 새로운 프런트엔드 ASIC 인 TEK061이 있어 최고 감도 설정에서 혁신적인 노이즈 성능을 제공합니다.

또한 새로운 고해상도 모드는 선택한 샘플 속도에 따라 하드웨어 기반의 고유한 FIR (Finite Impulse Response) 필터를 적용합니다. FIR 필터는 해당 샘플 속도에 대해 가능한 최대 대역폭을 유지하면서 디지타이저 증폭기 및 ADC에서 앨리어싱을 방지하고 선택한 샘플 속도에 대해 사용 가능한 대역폭 이상으로 노이즈를 제거합니다. 고해상도 모드는 항상 최소 12 비트의 수직 해상도를 제공하며 ≤ 625 MS/s 샘플 속도 및 200 MHz의 대역폭에서 16 비트의 수직 해상도로 확장됩니다.

간편한 리모콘



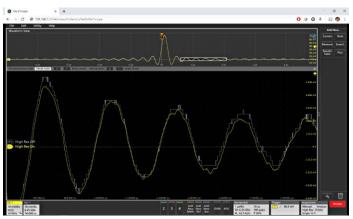
간편한 원격 제어를 위해 테스트 랙에 6 시리즈 로우 프로파일 디지타이저를 프로그래밍하는 것이 결코 쉬운 일이 아닙니다.

자동화 된 테스트 장비 및 다중 채널 시스템에는 강력한 프로그래밍 기능이 필요하며 종종 랙 공간 제약 및 / 또는 속도 제한이 적용됩니다. 6 시리즈 로우 프로파일 디지타이저는 4 개의 고성능 25GS / s 채널을 단 2 개의 랙 장치에 포장하여 랙에 장착 할 수 있습니다. 각 입력은 추가 분석을 위해 1000Base-T 이더넷 또는 Super Speed USB 3.0 포트를 통해 로컬 PC로 전송할 수있는 다중 원격 인터페이스를 갖춘 정밀 아날로그 채널 및 / 또는 스펙트럼 채널로 작동 할 수 있습니다. 광범위한 프로그래밍 언어 지원 및 GitHub 리포지토리를 통해 새로운 디지타이저를 테스트 랙에 쉽게 통합 할 수있는 여러 가지 방법이 있습니다.

주요 원격 액세스 기능은 다음과 같습니다.

- 랙 마운트가 장착 된 2 개의 랙 유닛 높이 (3.5 인치)
- 쉬운 웹 브라우저 원격 액세스 및 제어
- LXI 1.5 인증 (VXI-11)
- 최대 800 Mbps 전송 속도의 이더넷 및 USB 3.0 (USBTMC) 장치 포트
- 1000 개 이상의 VISA 명령이 있는 프로그래머 매뉴얼
- 프로그래밍 지원 : IVI-C, IVI-COM, MATLAB, LabView, Python, VISA, Sockets, VOSS Scientific 등
- Tektronix GitHub 프로그래밍 예 (https://github.com/tektronix/Programmatic-Control-Examples)

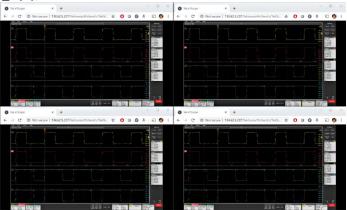




Chrome, Firefox 또는 Edge와 같은 브라우저에서 e*Scope를 사용한 간편한 원격 제어

e*Scope는 표준 웹 브라우저를 통해 네트워크 연결을 통해 5 시리 즈 또는 6 시리즈 오실로스코프 또는 디지타이저를 직접 원격으로 제 어하는 쉬운 원격보기 방법입니다.

계측기 IP 주소를 최신 브라우저에 입력하면 LXI 랜딩 페이지가 표시되고 계측기 컨트롤을 선택하여 e*scope에 액세스하십시오. 인스트루먼트 화면이나 연결된 모니터를 사용하여 연결된 것처럼 드라이버가 필요하지 않으며 브라우저에서 자체 유지됩니다. 데이터를 시각화하기 위한 단일 또는 다중 계측기 상황에 빠르고 반응이 빠르고 완벽합니다.



보기 위해 모니터의 브라우저 탭을 바둑판 식으로 배열하여 여러 기기에서 e*Scope를 사용한 간편한 원격 제어

동기화



수동 지연 보정 및 Aux 트리거 입력을 사용하여 200 ps 내에서 여러 계측기 채 널 동기화

여러 계측기를 동기화 할 때 계측기 채널간에 가장 적은 양의 스큐를 가져야 데이터 타이밍 정확도를 얻을 수 있습니다. 일반적으로 이것은 두 가지 유형의 왜곡으로 나눌 수 있습니다. 보조 트리거와 아날로 그 채널 사이의 불확실성에서 오는 부분과 트리거 지터에서 오는 부분. Aux 입력에 대한 채널 지연의 영향을 보정하여 계측기 채널 간 타이밍 부정확의 정도를 지터로 줄일 수 있습니다. 이 과정을 계측기 왜곡 보정이라고합니다.

트리거링 에지 (바람직하게는 1 Vpp 이상)를 여러 계측기의 Aux Trigger 입력과 기준 채널에 동시에 공급하는 기준 채널에 대해 왜곡보정을 수행 할 수 있습니다. 모든 것이 조정되면, 계측기 대 계측기채널은 단지 몇 개의 샘플 포인트에 대한 허용 오차 내에서 그리고 200 ps의 사양 내에있을 수 있습니다. 16 채널이든 200 채널이든 관계없이 모든 데이터를 쉽게 동기화하고 분석 할 수 있습니다.

강화 된 보안 옵션

옵션 6-SEC 보안 강화 옵션을 사용하면 모든 계측기 I / O 포트 및 펌 웨어 업그레이드의 암호로 보호 된 활성화 / 비활성화가 가능합니다. 또한 옵션 6-SEC는 NISPOM (National Industrial Security Program Operating Manual) DoD 5220.22-M, 8 장 요구 사항 및 방어 보안 서비스에 따라 내부 메모리에 사용자 설정 또는 파형 데이터를 저장하지 않도록하여 최고 수준의 보안을 제공합니다. NISPOM에 따라 분류 된 시스템의 인증 및 인증 매뉴얼. 이를 통해 장비를 안전한 장소 밖으로 안전하게 이동할 수 있습니다.

임의 함수 발생기 (AFG)

이 계측기에는 옵션으로 내장 된 임의 / 함수 발생기가 포함되어 있어 설계 내에서 센서 신호를 시뮬레이션 하거나 신호에 노이즈를 추가하여 마진 테스트를 수행하는 데 적합합니다. 통합 함수 발생기는 사인, 구형, 펄스, 램프 / 삼각형, DC, 노이즈, sin (x) / x (Sinc), 가우스, 로 렌츠, 지수 상승 / 하강, 하버 사인 및 심장에 대해 최대 50MHz의 사전 정의 된 파형의 출력을 제공합니다. AFG는 내부 파일 위치 또는 USB 대용량 저장 장치에서 최대 128k 포인트 크기의 파형 레코드를 로드 할 수 있습니다.

디지털 전압계 (DVM) 및 트리거 주파수 카운터

계측기에는 통합 4 자리 디지털 전압계 (DVM) 및 8 자리 트리거 주파수 카운터가 포함되어 있습니다. 모든 아날로그 입력은 일반 오실로 스코프 사용을 위해 이미 연결된 동일한 프로브를 사용하여 전압계의 소스가 될 수 있습니다. 트리거 빈도 카운터는 트리거 중인 트리거 이벤트의 빈도를 매우 정확하게 판독합니다.

DVM 및 트리거 주파수 카운터는 모두 무료로 제공되며 제품을 등록할 때 활성화됩니다.



제품 사양

달리 명시되지 않는 한 모든 사양이 보장됩니다. 달리 명시되지 않는 한 모든 사양은 모든 모델에 적용됩니다.

Model overview

LPD64 Low Profile Digitizer

Characteristic	LPD64
Analog inputs	4
Bandwidth (calculated rise time)	1 GHz (400 ps), 2.5 GHz (160 ps), 4 GHz (100 ps), 6 GHz (66.67 ps), 8 GHz (50 ps)
DC Gain Accuracy	50 Ω : $\pm 2.0\%$ ¹ , ($\pm 2.0\%$ at 2 mV/div, $\pm 4.0\%$ at 1 mV/div, typical) 50 Ω : $\pm 1.0\%$ ² of full scale, ($\pm 1.0\%$ of full scale at 2 mV/div, $\pm 2.0\%$ at 1 mV/div, typical)
ADC Resolution	12 bits
Vertical Resolution (all channels)	8 bits @ 25 GS/s; 8 GHz 12 bits @ 12.5 GS/s; 4 GHz 13 bits @ 6.25 GS/s (High Res); 2 GHz 14 bits @ 3.125 GS/s (High Res); 1 GHz 15 bits @ 1.25 GS/s (High Res); 500 MHz 16 bits @ ≤625 MS/s (High Res); 200 MHz
Sample Rate	25 GS/s on all channels
Record Length	125 Mpoints on all channels (standard) 250 Mpoints on all channels (optional)
Waveform Capture Rate	>500,000 wfms/s (Peak Detect, Envelope acquisition mode), >30,000 wfms/s (all other acquisition modes)
Arbitrary/Function Generator (option)	13 predefined waveform types with up to 50 MHz output
DVM	4-digit DVM (free with product registration)
Trigger Frequency Counter	8-digit frequency counter (free with product registration)

Vertical system

Input coupling	DC
Input impedance 50 Ω , DC coupled	50 Ω ±3%
Input sensitivity range	
50 Ω	1 mV/div to 1 V/div in a 1-2-5 sequence
	Note: 1 mV/div is a 2X digital zoom of 2 mV/div.
Maximum input voltage	50 Ω : 2.5 V _{RMS} at <100 mV/div, with peaks \leq ±20 V (DF \leq 6.25%)
	50 Ω: 5 V _{RMS} at ≥100 mV/div, with peaks ≤ ±20 V (DF ≤ 6.25%)

² Warranted specification, immediately after SPC, add 1% for every 5 °C change in ambient temperature. At full scale is sometimes used to compare to other manufactures.



Warranted specification, immediately after SPC, add 2% for every 5 °C change in ambient temperature.

Vertical system

Effective bits (ENOB), typical

2 mV/div, High Res mode, 50 Ω , 10 MHz input with 90% full screen

Bandwidth	ENOB
4 GHz	5.9
3 GHz	6.1
2.5 GHz	6.2
2 GHz	6.35
1 GHz	6.8
500 MHz	7.2
350 MHz	7.4
250 MHz	7.5
200 MHz	7.75
20 MHz	8.8

50 mV/div, High Res mode, 50 $\Omega,$ 10 MHz input with 90% full screen

Bandwidth	ENOB
4 GHz	7.25
3 GHz	7.5
2.5 GHz	7.6
2 GHz	7.8
1 GHz	8.2
500 MHz	8.5
350 MHz	8.8
250 MHz	8.9
200 MHz	9
20 MHz	9.8



Vertical system

2 mV/div, Sample mode, 50 Ω , 10 MHz input with 90% full screen

Bandwidth	ENOB
8 GHz	5.1
7 GHz	5.3
6 GHz	5.5
5 GHz	5.65
4 GHz	5.9
3 GHz	6.05
2.5 GHz	6.2
2 GHz	6.35
1 GHz	6.8
500 MHz	7.2
350 MHz	7.3
250 MHz	7.5
200 MHz	7.3
20 MHz	7.6

50 mV/div, Sample mode, 50 Ω , 10 MHz input with 90% full screen

Bandwidth	ENOB
8 GHz	6.5
7 GHz	6.6
6 GHz	6.8
5 GHz	7
4 GHz	7.2
3 GHz	7.4
2.5 GHz	7.6
2 GHz	7.7
1 GHz	8.2
500 MHz	8.4
350 MHz	8.7
250 MHz	8.8
200 MHz	7.8
20 MHz	7.9

DC balance

0.1 div with DC-50 Ω digitizer input impedance (50 Ω terminated)

0.2 div at 1 mV/div with DC-50 Ω digitizer input impedance (50 Ω terminated)

Position range

±5 divisions

Offset ranges, maximum

Input signal cannot exceed maximum input voltage for the 50 $\boldsymbol{\Omega}$ input path.

Volts/div Setting	Maximum offset range, 50 Ω Input
1 mV/div - 99 mV/div	±1 V
100 mV/div - 1 V/div	±10 V

Offset accuracy

±(0.005 X | offset - position | + DC balance); Offset, position, and DC Balance in units of Volts



Vertical system

Bandwidth selections

8 GHz model, 50 Ohm 20 MHz, 200 MHz, 250 MHz, 350 MHz, 500 MHz, 1 GHz, 2 GHz, 2 GHz, 3 GHz, 4 GHz, 5 GHz, 6 GHz, 7 GHz, and 8 GHz

6 GHz model, 50 Ohm 20 MHz, 250 MHz, 350 MHz, 500 MHz, 1 GHz, 2 GHz, 2.5 GHz, 3 GHz, 4 GHz, 5 GHz, and 6 GHz

4 GHz model, 50 Ohm 20 MHz, 200 MHz, 250 MHz, 350 MHz, 500 MHz, 1 GHz, 2 GHz, 2.5 GHz, 3 GHz, and 4 GHz

2.5 GHz model, 50 Ohm 20 MHz, 200 MHz, 250 MHz, 350 MHz, 500 MHz, 1 GHz, 2 GHz, and 2.5 GHz

1 GHz model, 50 Ohm 20 MHz, 200 MHz, 250 MHz, 350 MHz, 500 MHz, and 1 GHz

Bandwidth filtering optimized for F

Flatness or Step response

Random noise, RMS, typical 50 Ω , typical

25 GS/s, Sample Mode, RMS

V/div	1 mV/div	2 mV/div	5 mV/div	10 mV/div	20 mV/div	50 mV/div	100 mV/ div	1 V/div
8 GHz	158 μV	158 µV	208 μV	342 μV	630 µV	1.49 mV	3.46 mV	29.7 mV
7 GHz	141 μV	143 µV	192 μV	311 μV	562 μV	1.31 mV	3.11 mV	26.2 mV
6 GHz	127 μV	127 µV	165 μV	274 μV	489 μV	1.18 mV	2.71 mV	23.6 mV
5 GHz	112 µV	113 µV	149 μV	239 μV	446 μV	1.05 mV	2.42 mV	21.1 mV

12.5 GS/s, HiRes Mode, RMS

V/div	1 mV/div	2 mV/div	5 mV/div	10 mV/div	20 mV/div	50 mV/div	100 mV/ div	1 V/div
4 GHz	97.4 μV	98.7 μV	124 µV	192 µV	344 µV	817 μV	1.92 mV	16.3 mV
3 GHz	82.9 µV	84 μV	105 μV	160 µV	282 μV	680 μV	1.62 mV	13.6 mV
2.5 GHz	76.5 µV	77.5 µV	93.8 µV	144 µV	257 μV	606 µV	1.44 mV	12.1 mV
2 GHz	68.1 μV	69.1 μV	83.6 µV	131 µV	226 μV	528 μV	1.28 mV	10.6 mV
1 GHz	54.8 μV	51.2 μV	63.4 μV	90.9 μV	160 μV	378 μV	941 µV	7.65 mV
500 MHz	39.7 µV	39.8 µV	48.1 μV	65.1 μV	115 µV	280 μV	666 µV	5.6 mV
350 MHz	33.8 µV	33.5 µV	40 μV	54.8 μV	94.3 µV	217 µV	560 μV	4.35 mV
250 MHz	30.8 µV	31.2 µV	36.1 µV	49.9 μV	80.3 µV	187 μV	482 μV	3.75 mV
200 MHz	25.3 µV	25.4 μV	29.7 μV	44 µV	70.7 μV	165 µV	445 µV	3.3 mV
20 MHz	8.68 µV	8.9 µV	10.4 μV	15.1 μV	27.5 μV	70.4 µV	158 µV	1.41 mV

Crosstalk (channel isolation), typical

 \geq -80 dB up to 2 GHz

 \geq -65 dB up to 4 GHz

 \geq -55 dB up to 8 GHz

for any two channels set to 200 mV/div.



Datasheet

Horizontal system

rizontal system									
Time base range	40 ps/div to 1,000 s/div								
Sample rate range	6.25 S/s to 25 GS/s (rea	I time)							
	50 GS/s to 2.5 TS/s (inte	erpolated)							
Record length range	All acquisition modes are	e 250 M max	imum record	length, down	to 1 k minir	num record le	ngth, adjustab	le in 1 sampl	e incremen
gg	Standard: 125 Mpoints							·	
	Option 6-RL-2: 250 Mpo	ints							
Seconds/Division range	Record length	1 K	10 K	100 K	1 M	10 M	62.5 M	125 M	250 M
· ·	Standard: 125 M	40 ps -	400 ps -	4 ns - 100		177	2.5 µs -	5 μs -	N/A
		16 s	160 s				1000 s	1000 s	
	Option 6-RL-2: 250 M	40 ps -	400 ps -	4 ps - 100	00 s		2.5 µs -	5 μs -	10 μs -
		16 s	160 s				1000 s	1000 s	1000 s
Aperture uncertainty	Time duration Typica	l jitter							
	<1 µs 80 fs								
	<1 ms 130 fs								
imebase accuracy	±1.0 x10 ⁻⁷ over any ≥1 ms time interval								
	Description Specification								
	Factory Tolerance			±12 ppb. At calibration, 25 °C ambient, over any ≥1 ms interval					
	Temperature stability			±20 ppb across the full operating range of 0 °C to 50 °C, after a sufficient soak time at the temperature. Tested at operating temperatures					
	Crystal aging			±300 ppb. Frequency tolerance change at 25 °C over a period of 1 year					
	or your aging								
Delta-time measurement accuracy	DTA _{pp} (typical) = 10 × _v								
	$DTA_{RMS} = \sqrt{\left(\frac{N}{SR_1}\right)^2 + \left(\frac{N}{SR_2}\right)^2 + \left(0.450 \text{ ps} + \left(1 \times 10^{-11} \times t_p\right)\right)^2} + TBA \times t_p$								
	(assume edge shape that results from Gaussian filter response)								
	The formula to calculate delta-time measurement accuracy (DTA) for a given instrument setting and input signal assumes insignificant signal content above Nyquist frequency, where:								
	SR ₁ = Slew Rate (1st Edge) around 1st point in measurement								
	SR ₂ = Slew Rate (2 nd Edge) around 2 nd point in measurement								
	N = input-referred guaranteed noise limit (V _{RMS})								
	TBA = timebase accurac	y or Referen	nce Frequency	/ Error					
	t _p = delta-time measurer	ment duration	n (sec)						
Maximum duration at highest	5 ms (standard) or 10 ms	s (option 6-R	RL-2, 250 Mpo	ints)					



sample rate

Time base delay time range

-10 divisions to 5,000 s

Horizontal system

Deskew range	-125 ns to +125 ns with a resolution of 40 ps (for Peak Detect and Envelope acquisition modes)125 ns to +125 ns with a resolution of 1 ps (for all other acquisition modes).
Delay between analog channels, full bandwidth, typical	≤ 10 ps for any two channels with input impedance set to 50 Ω, DC coupling with equal Volts/div or above 10 mV/div

Trigger system

Trigger modes	Auto, Normal, and Single		
Trigger coupling	DC, HF Reject (attenuates > 50 kHz), LF Reject (attenuates < 50 kHz), noise reject (reduces sensitivity)		
Trigger bandwidth (edge, pulse	Model	Trigger type	Trigger bandwidth

and logic), typical

Model	Trigger type	Trigger bandwidth
8 GHz	Edge	8 GHz
8 GHz	Pulse, Logic	4 GHz
6 GHz	Edge	6 GHz
6 GHz	Pulse, Logic	4 GHz
4 GHz, 2.5 GHz, 1 GHz:	Edge, Pulse, Logic	Product Bandwidth

Edge-type trigger sensitivity, DC coupled, typical

Path	Range	Specification
50 Ω path	1 mV/div to 9.98 mV/div	3.0 div from DC to instrument bandwidth
	≥ 10 mV/div	< 1.0 division from DC to instrument bandwidth
Line	90 V to 264 V line voltage at 50 - 60 Hz line frequency	103.5 V to 126.5 V
AUX Trigger in		250 mV _{PP} , DC to 400 MHz

Edge-type trigger sensitivity, not DC coupled, typical

Trigger Coupling	Typical Sensitivity
NOISE REJ	2.5 times the DC Coupled limits
HF REJ 1.0 times the DC Coupled limits from DC to 50 kHz. Attenuates signals above 50	
LF REJ	1.5 times the DC Coupled limits for frequencies above 50 kHz. Attenuates signals below 50 kHz.

Trigger jitter, typical ≤ 1.5 ps_{RMS} for sample mode and edge-type trigger

≤ 7 ps_{RMS} ≤ 2 ps_{RMS} for edge-type trigger and FastAcq mode

≤ 40 ps_{RMS} for non edge-type trigger modes

 \leq 40 ps_{RMS} for AUX trigger in, Sample acquisition mode, edge trigger

≤ 40 ps_{RMS} for AUX trigger in, FastAcq acquisition mode, edge trigger

Trigger jitter, AUX input, typical \leq 200 ps_{RMS} for sample mode and edge-type trigger

≤ 220 ps_{RMS} for edge-type trigger and FastAcq mode

AUX In trigger skew between instruments, typical

±100 ps jitter on each instrument with <450 ps skew; <550 ps total between instruments. Can be manually deskewed so channelto-channel total skew is <200ps between instruments using AUX In.

Skew improves for pulse input voltages ≥1 V_{pp}



Trigger system

Trigger level ranges

Source	Range
Any Channel	±5 divs from center of screen
Aux In Trigger	±5 V
Line	Fixed at about 50% of line voltage

This specification applies to logic and pulse thresholds.

Trigger frequency counter

8-digits (free with product registration)

Trigger types

Edge: Positive, negative, or either slope on any channel. Coupling includes DC, AC, noise reject, HF reject, and LF reject

Pulse Width: Trigger on width of positive or negative pulses. Event can be time- or logic-qualified

Timeout: Trigger on an event which remains high, low, or either, for a specified time period. Event can be logic-qualified

Runt: Trigger on a pulse that crosses one threshold but fails to cross a second threshold before crossing the first again. Event can be

time- or logic-qualified

Window: Trigger on an event that enters, exits, stays inside or stays outside of a window defined by two user-adjustable thresholds. Event

can be time- or logic-qualified

Logic: Trigger when logic pattern goes true, goes false, or occurs coincident with a clock edge. Pattern (AND, OR, NAND, NOR) specified

for all input channels defined as high, low, or don't care. Logic pattern going true can be time-qualified

Setup & Hold: Trigger on violations of both setup time and hold time between clock and data present on any input channels

Rise / Fall Time: Trigger on pulse edge rates that are faster or slower than specified. Slope may be positive, negative, or either. Event can be logic-

qualified

Video: Trigger on all lines, odd, even, or all fields of NTSC, PAL, and SECAM video signals

Sequence: Trigger on B event X time or N events after A trigger with a reset on C event. In general, A and B trigger events can be set to any

trigger type with a few exceptions: logic qualification is not supported, if A event or B event is set to Setup & Hold, then the other

must be set to Edge, and Ethernet and High Speed USB (480 Mbps) are not supported

Visual trigger Qualifies standard triggers by scanning all waveform acquisitions and comparing them to on-screen areas (geometric shapes). An

unlimited number of areas can be defined with In, Out, or Don't Care as the qualifier for each area. A boolean expression can be defined using any combination of visual trigger areas to further qualify the events that get stored into acquisition memory. Shapes

include rectangle, triangle, trapezoid, hexagon and user-defined

Parallel Bus: Trigger on a parallel bus data value. Parallel bus can be from 1 to 4 bits (from the analog channels) in size. Supports Binary and

Hex radices

I²C Bus (option 6-SREMBD): Trigger on Start, Repeated Start, Stop, Missing ACK, Address (7 or 10 bit), Data, or Address and Data on I²C buses up to 10 Mb/s

SPI Bus (option 6-SREMBD): Trigger on Slave Select, Idle Time, or Data (1-16 words) on SPI buses up to 20 Mb/s

RS-232/422/485/UART Bus (option 6-SRCOMP):

Trigger on Start Bit, End of Packet, Data, and Parity Error up to 15 Mb/s

CAN Bus (option 6-SRAUTO): Trigger on Start of Frame, Type of Frame (Data, Remote, Error, or Overload), Identifier, Data, Identifier and Data, End Of Frame,

Missing Ack, and Bit Stuff Error on CAN buses up to 1 Mb/s

CAN FD Bus (option 6-

SRAUTO):

Trigger on Start of Frame, Type of Frame (Data, Remote, Error, or Overload), Identifier (Standard or Extended), Data (1-8 bytes), Identifier and Data, End Of Frame, Error (Missing Ack, Bit Stuffing Error, FD Form Error, Any Error) on CAN FD buses up to

16 Mb/s

LIN Bus (option 6-SRAUTO):

FlexRay Bus (option 6-

SRAUTO):

Trigger on Sync, Identifier, Data, Identifier and Data, Wakeup Frame, Sleep Frame, and Error on LIN buses up to 1 Mb/s

Trigger on Start of Frame, Indicator Bits (Normal, Payload, Null, Sync, Startup), Frame ID, Cycle Count, Header Fields (Indicator Bits, Identifier, Payload Length, Header CRC, and Cycle Count), Identifier, Data, Identifier and Data, End Of Frame, and Errors on

FlexRay buses up to 10 Mb/s

SENT Bus (option 6-SRAUTOSEN) Trigger on Start of Packet, Fast Channel Status and Data, Slow Channel Message ID and Data, and CRC Errors

SPMI Bus (option 6-SRPM): Trigger on Sequence Start Condition, Reset, Sleep, Shutdown, Wakeup, Authenticate, Master Read, Master Write, Register Read,

Register Write, Extended Register Read, Extended Register Write, Extended Register Read Long, Extended Register Write Long, Device Descriptor Block Master Read, Device Descriptor Block Slave Read, Register 0 Write, Transfer Bus Ownership, and Parity

Erro

USB 2.0 LS/FS/HS Bus (option

6-SRUSB2):

Trigger on Sync, Reset, Suspend, Resume, End of Packet, Token (Address) Packet, Data Packet, Handshake Packet, Special

Packet, Error on USB buses up to 480 Mb/s



Trigger system

Trigger holdoff range	0 ns to 10 seconds
ARINC 429 Bus (option 6- SRAERO):	Trigger on Word Start, Label, Data, Label and Data, Word End, and Error (Any Error, Parity Error, Word Error, Gap Error) on ARINC 429 buses up to 1 Mb/s
MIL-STD-1553 Bus (option 6- SRAERO):	Trigger on Sync, Command (Transmit/Receive Bit, Parity, Subaddress / Mode, Word Count / Mode Count, RT Address), Status (Parity, Message Error, Instrumentation, Service Request, Broadcast Command Received, Busy, Subsystem Flag, Dynamic Bus Control Acceptance, Terminal Flag), Data, Time (RT/IMG), and Error (Parity Error, Sync Error, Manchester Error, Non-contiguous Data) on MIL-STD-1553 buses
Audio (I ² S, LJ, RJ, TDM) Bus (option 6-SRAUDIO):	Trigger on Word Select, Frame Sync, or Data. Maximum data rate for I ² S/LJ/RJ is 12.5 Mb/s. Maximum data rate for TDM is 25 Mb/s
Ethernet Bus (option 6- SRENET):	Trigger on Start of Frame, MAC Addresses, MAC Q-tag, MAC Length/Type, MAC Data, IP Header, TCP Header, TCP/IPV4 Data, End of Packet, and FCS (CRC) Error on 10BASE-T and 100BASE-TX buses

Acquisition system

Sample	Acquires sampled values
Peak Detect	Captures glitches as narrow as at all sweep speeds
Averaging	From 2 to 10,240 waveforms
Envelope	Min-max envelope reflecting Peak Detect data over multiple acquisitions
High Res	Applies a unique Finite Impulse Response (FIR) filter for each sample rate that maintains the maximum bandwidth possible for that sample rate while preventing aliasing and removing noise from the oscilloscope amplifiers and ADC above the usable bandwidth for the selected sample rate.
	High Res mode always provides at least 12 bits of vertical resolution and extends all the way to 16 bits of vertical resolution at ≤ 625 MS/s sample rates.
FastAcq [®]	FastAcq optimizes the instrument for analysis of dynamic signals and capture of infrequent events.
	Maximum waveform capture rate:
	>500,000 wfms/s (Peak Detect or Envelope Acquisition mode)
	>30,000 wfms/s (All other acquisition modes)
Roll mode	Scrolls sequential waveform points across the display in a right-to-left rolling motion, at timebase speeds of 40 ms/div and slower, when in Auto trigger mode.
FastFrame [™]	Acquisition memory divided into segments.
	Maximum trigger rate >5,000,000 waveforms per second
	Minimum frame size = 50 points
	Maximum Number of Frames: For frame size ≥ 1,000 points, maximum number of frames = record length / frame size.
	For 50 point frames, maximum number of frames = 691,000



Waveform measurements

Cursor types	Waveform, V Bars, H Bars, V&H Bars, and Polar (XY/XYZ plots	s only)
DC voltage measurement	Measurement Type	DC Accuracy (In Volts)
accuracy, Average acquisition mode	Average of ≥ 16 waveforms	±((DC Gain Accuracy) * reading - (offset - position) + Offset Accuracy + 0.05 * V/div setting)
	Delta volts between any two averages of ≥ 16 waveforms acquired with the same oscilloscope setup and ambient conditions	±(DC Gain Accuracy * reading + 0.1 div)
Automatic measurements	36, of which an unlimited number can be displayed as either incresults table	dividual measurement badges or collectively in a measurement
Amplitude measurements	Amplitude, Maximum, Minimum, Peak-to-Peak, Positive Oversh Area	noot, Negative Overshoot, Mean, RMS, AC RMS, Top, Base, and
Timing measurements	Period, Frequency, Unit Interval, Data Rate, Positive Pulse Width, Negative Pulse Width, Skew, Delay, Rise Time, Fall Time, Phase, Rising Slew Rate, Falling Slew Rate, Burst Width, Positive Duty Cycle, Negative Duty Cycle, Time Outside Level, Setup Time, Hold Time, Duration N-Periods, High Time, and Low Time	
Jitter measurements (standard)	TIE and Phase Noise	
Measurement statistics	Mean, Standard Deviation, Maximum, Minimum, and Population. Statistics are available on both the current acquisition and all acquisitions	
Reference levels	User-definable reference levels for automatic measurements can be specified in either percent or units. Reference levels can be set to global for all measurements, per source channel or signal, or unique for each measurement	
Gating	Screen, Cursors, Logic, Search, or Time. Specifies the region of an acquisition in which to take measurements. Gating can be set to Global (affects all measurements set to Global) or Local (all measurements can have a unique Time gate setting; only one Local gate is available for Screen, Cursors, Logic, and Search actions).	
Measurement plots	Histogram, Time Trend, Spectrum, Eye Diagram (TIE measure	ment only), Phase Noise (Phase Noise measurement only)
	Fast eye rendering: Shows the Unit Intervals (UIs) that define the surrounding UIs for added visual context	he boundaries of the eye along with a user specified number of
	Complete eye rendering: Shows all valid Unit Intervals (UIs)	
Measurement limits	Pass/fail testing for user-definable limits on measurement values. Act on event for measurement value failures include Save Screen Capture, Save Waveform, System Request (SRQ), and Stop Acquisitions	
Jitter analysis (option 6-DJA) adds the following:		
Measurements	Measurements Jitter Summary, TJ@BER, RJ- δδ, DJ- δδ, PJ, RJ, DJ, DDJ, DCD, SRJ, J2, J9, NPJ, F/2, F/4, F/8, Eye Height, Eye Height Eye Width, Eye Width@BER, Eye High, Eye Low, Q-Factor, Bit High, Bit Low, Bit Amplitude, DC Common Mode, AC Common Mode (Pk-Pk), Differential Crossover, T/nT Ratio, SSC Freq Dev, SSC Modulation Rate	
Measurement plots	Eye Diagram and Jitter Bathtub	
	Fast eye rendering: Shows the Unit Intervals (UIs) that define the surrounding UIs for added visual context	he boundaries of the eye along with a user specified number of
	Complete eye rendering: Shows all valid Unit Intervals (UIs)	
Measurement limits	Pass/fail testing for user-definable limits on measurement value Screen Capture, Save Waveform, System Request (SRQ), and	
Eye diagram mask testing	Automated mask pass/fail testing	



Waveform measurements

Power analysis	adds th	e followina:
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Measurements Input Analysis (Frequency, V_{RMS}, I_{RMS}, voltage and current Crest Factors, True Power, Apparent Power, Reactive Power, Power

Factor, Phase Angle, Harmonics, Inrush Current, Input Capacitance)

Amplitude Analysis (Cycle Amplitude, Cycle Top, Cycle Base, Cycle Maximum, Cycle Minimum, Cycle Peak-to-Peak)

Timing Analysis (Period, Frequency, Negative Duty Cycle, Positive Duty Cycle, Negative Pulse Width, Positive Pulse Width)

Switching Analysis (Switching Loss, dv/dt, di/dt, Safe Operating Area, R_{DSon})

Magnetic Analysis (Inductance, I vs. Intg(V), Magnetic Loss, Magnetic Property)

Output Analysis (Line Ripple, Switching Ripple, Efficiency, Turn-on Time, Turn-off Time)

Frequency Response Analysis (Control Loop Response Bode Plot, Power Supply Rejection Ratio, Impedance)

Measurement Plots Harmonics Bar Graph, Switching Loss Trajectory Plot, and Safe Operating Area

Digital Power Management adds

the following:

Measurements Ripple Analysis (Ripple)

Transient Analysis (Overshoot, Undershoot, Turn On Overshoot, DC Rail Voltage)

Power Sequence Analysis (Turn-on, Turn-off)

Jitter Analysis (TIE, PJ, RJ, DJ, Eye Height, Eye Width, Eye High, Eye Low)

DDR3/LPDDR3 memory debug and analysis option (6-DBDDR3) adds

the following:

Measurements Amplitude Measurements (AOS, AUS, Vix(ac), AOS Per tCK, AUS Per tCK, AOS Per UI, AUS Per UI)

Time Measurements (tRPRE, tWPRE, tPST, Hold Diff, Setup Diff, tCH(avg), tCK(avg), tCL(avg), tCH(abs), tCL(abs), tJIT(duty),

tJIT(per), tJIT(cc), tERR(n), tERR(m-n), tDQSCK, tCMD-CMD, tCKSRE, tCKSRX)

LVDS debug and analysis option (option 6-DBLVDS) adds the

following:

Data Lane Measurements Generic Test (Unit Interval, Rise Time, Fall Time, Data Width, Data Intra Skew (PN), Data Inter Skew (Lane-to-Lane), Data Peak-

to-Peak)

Jitter Test (AC Timing, Clock Data Setup Time, Clock Data Hold Time, Eye Diagram (TIE), TJ@BER, DJ Delta, RJ Delta, DDJ, De-

Emphasis Level)

Clock Lane Measurements Generic Test (Frequency, Period, Duty Cycle, Rise Time, Fall Time, Clock Intra Skew (PN), Clock Peak-to-Peak)

Jitter Test (TIE, DJ, RJ)

SSC On (Mod Rate, Frequency Deviation Mean)

Waveform math

Number of math waveforms	Unlimited	
Arithmetic	Add, subtract, multiply, and divide waveforms and scalars	
Algebraic expressions	Define extensive algebraic expressions including waveforms, scalars, user-adjustable variables, and results of parametric measurements. Perform math on math using complex equations. For example (Integral (CH1 - Mean(CH1)) X 1.414 X VAR1)	
Math functions	Invert, Integrate, Differentiate, Square Root, Exponential, Log 10, Log e, Abs, Ceiling, Floor, Min, Max, Degrees, Radians, Sin, Cos, Tan, ASin, ACos, and ATan	
Relational	Boolean result of comparison $>$, $<$, \ge , \le , $=$, and \ne	



Datasheet

Waveform math

vvaveioiiii iiialii			
Logic	AND, OR, NAND, NOR, XOR, and EQV		
Filtering function	User-definable filters. Users specify a file containing the coefficients of the filter		
FFT functions	Spectral Magnitude and Phase, and Real and	Imaginary Spectra	
FFT vertical units	Magnitude: Linear and Log (dBm)		
	Phase: Degrees, Radians, and Group Delay		
FFT window functions	Hanning, Rectangular, Hamming, Blackman-h	Harris, Flattop2, Gaussian, Kaiser-Bessel, and TekExp	
Spectrum View			
Center Frequency	Limited by instrument analog bandwidth		
Span	74.5 Hz – 1.25 GHz (standard)		
	74.5 Hz – 2 GHz (option 6-SV-BW-1)		
	Coarse adjustment in a 1-2-5 sequence		
RF vs. Time Traces	Magnitude vs. time, Frequency vs. time, Phase vs. Time		
Resolution Bandwidth (RBW)	93 µHz to 62.5 MHz		
	93 μHz to 100 MHz (option 6-SV-BW-1)		
Window types and factors	Window type	Factor	
	Blackman-Harris	1.90	
	Flat-Top 2	3.77	
	Hamming	1.30	
	Hanning	1.44	
	Kaiser-Bessel	2.23	
	Rectangular	0.89	
Spectrum Time	FFT Window Factor / RBW		
Reference level	Reference level is automatically set by the analog channel Volts/div setting		
	Setting range: -42 dBm to +44 dBm		
Vertical Position	-100 divs to +100 divs		



dBm, dB μ W, dBmV, dB μ V, dBmA, dB μ A

Linear, Log

Vertical units

Horizontal scaling

Search

Se	earch		
Number of searches Unlimited		Unlimited	
Search types Search through long records to find all occurrences of user specified criteria including edges, pulse widths, tim window violations, logic patterns, setup & hold violations, rise/fall times, and bus protocol events. Search result the Waveform View or in the Results table.			
Sa	ave		
	Waveform Type	Tektronix Waveform Data (.wfm), Comma Separated Values (.csv), MATLAB (.mat)	
	Waveform Gating	Cursors, Screen, Resample (save every nth sample)	
	Screen Capture Type	Portable Network Graphic (*.png), 24-bit Bitmap (*.bmp), JPEG (*.jpg)	
	Setup Type	Tektronix Setup (.set)	
	Report Type	Adobe Portable Documents (.pdf), Single File web Pages (.mht)	
	Session Type	Tektronix Session Setup (.tss)	
Di	splay		
	Display type	External monitor	
		1,920 horizontal × 1,080 vertical pixels (High Definition)	
	Display modes	Overlay: traditional oscilloscope display where traces overlay each other	
		Stacked: display mode where each waveform is placed in its own slice and can take advantage of the full ADC range while still being visually separated from other waveforms. Groups of channels can also be overlaid within a slice to simplify visual comparison of signals.	
	Zoom	Horizontal and vertical zooming is supported in all waveform and plot views.	
	Interpolation	Sin(x)/x and Linear	
	Waveform styles	Vectors, dots, variable persistence, and infinite persistence	
	Graticules	Movable and fixed graticules, selectable between Grid, Time, Full, and None	
Color palettes Normal and inverted for screen captures		Normal and inverted for screen captures	
Individual waveform colors are user-selectable		Individual waveform colors are user-selectable	
	Format	YT, XY, and XYZ	
	Local Language User Interface	English, Japanese, Simplified Chinese, Traditional Chinese, French, German, Italian, Spanish, Portuguese, Russian, Korean	
	Local Language Help	English, Japanese, Simplified Chinese	



Arbitrary-Function Generator optional

Function types Arbitrary, sine, square, pulse, ramp, triangle, DC level, Gaussian, Lorentz, exponential rise/fall, sin(x)/x, random noise, Haversine,

Cardiac

Amplitude range

Values are peak-to-peak voltages

Waveform	50 Ω	1 ΜΩ
Arbitrary	10 mV to 2.5 V	20 mV to 5 V
Sine	10 mV to 2.5 V	20 mV to 5 V
Square	10 mV to 2.5 V	20 mV to 5 V
Pulse	10 mV to 2.5 V	20 mV to 5 V
Ramp	10 mV to 2.5 V	20 mV to 5 V
Triangle	10 mV to 2.5 V	20 mV to 5 V
Gaussian	10 mV to 1.25 V	20 mV to 2.5 V
Lorentz	10 mV to 1.2 V	20 mV to 2.4 V
Exponential Rise	10 mV to 1.25 V	20 mV to 2.5 V
Exponential Fall	10 mV to 1.25 V	20 mV to 2.5 V
Sine(x)/x	10 mV to 1.5 V	20 mV to 3.0 V
Random Noise	10 mV to 2.5 V	20 mV to 5 V
Haversine	10 mV to 1.25 V	20 mV to 2.5 V
Cardiac	10 mV to 2.5 V	20 mV to 5 V

Sine waveform

0.1 Hz to 50 MHz Frequency range

Frequency setting resolution 0.1 Hz

130 ppm (frequency ≤ 10 kHz), 50 ppm (frequency > 10 kHz) Frequency accuracy

This is for Sine, Ramp, Square and Pulse waveforms only.

Amplitude range 20 mV $_{pp}$ to 5 V $_{pp}$ into Hi-Z; 10 mV $_{pp}$ to 2.5 V $_{pp}$ into 50 Ω

Amplitude flatness, typical ±0.5 dB at 1 kHz

±1.5 dB at 1 kHz for < 20 mV_{pp} amplitudes

Total harmonic distortion,

typical

1% for amplitude \geq 200 mV_{pp} into 50 Ω load

2.5% for amplitude > 50 mV AND < 200 mV $_{pp}$ into 50 Ω load

This is for Sine wave only.

Spurious free dynamic range,

typical

40 dB ($V_{pp} \ge 0.1 \text{ V}$); 30 dB ($V_{pp} \ge 0.02 \text{ V}$), 50 Ω load

Square and pulse waveform

0.1 Hz to 25 MHz Frequency range

Frequency setting resolution

130 ppm (frequency \leq 10 kHz), 50 ppm (frequency > 10 kHz) Frequency accuracy 20 mV $_{pp}$ to 5 V $_{pp}$ into Hi-Z; 10 mV $_{pp}$ to 2.5 V $_{pp}$ into 50 Ω Amplitude range 10% - 90% or 10 ns minimum pulse, whichever is larger **Duty cycle range**

Minimum pulse time applies to both on and off time, so maximum duty cycle will reduce at higher frequencies to maintain 10 ns off

time

0.1% **Duty cycle resolution**

Minimum pulse width, typical 10 ns. This is the minimum time for either on or off duration.

5 ns. 10% - 90%

Rise/Fall time, typical

Pulse width resolution 100 ps



Arbitrary-Function Generator optional

Overshoot, typical < % for signal steps greater than 100 mV_{pp}

This applies to overshoot of the positive-going transition (+overshoot) and of the negative-going (-overshoot) transition

Asymmetry, typical ±1% ±5 ns, at 50% duty cycle

Jitter, typical < 60 ps TIE_{RMS}, ≥ 100 mV_{pp} amplitude, 40%-60% duty cycle

Ramp and triangle waveform

Frequency range 0.1 Hz to 500 kHz

Frequency setting resolution 0.1 Hz

Frequency accuracy 130 ppm (frequency \leq 10 kHz), 50 ppm (frequency > 10 kHz) Amplitude range 20 mV_{pp} to 5 V_{pp} into Hi-Z; 10 mV_{pp} to 2.5 V_{pp} into 50 Ω

Variable symmetry 0% - 100% Symmetry resolution 0.1%

DC level range ±2.5 V into Hi-Z

 $\pm 1.25~V$ into 50 Ω

 $\textbf{Random noise amplitude range} \hspace{1cm} 20 \text{ mV}_{pp} \text{ to 5 V}_{pp} \text{ into Hi-Z}$

10 mV $_{pp}$ to 2.5 V $_{pp}$ into 50 Ω

Sin(x)/x

Maximum frequency 2 MHz

Gaussian pulse, Haversine, and

Lorentz pulse

Maximum frequency 5 MHz

Lorentz pulse

Frequency range 0.1 Hz to 5 MHz

 ${\bf Amplitude\ range} \qquad \qquad 20\ {\rm mV_{pp}\ to}\ 2.4\ {\rm V_{pp}\ into}\ {\rm Hi\text{-}Z}$

10 mV $_{pp}$ to 1.2 V_{pp} into 50 Ω

Cardiac

Frequency range 0.1 Hz to 500 kHz

Amplitude range 20 mV $_{pp}$ to 5 V $_{pp}$ into Hi-Z

10 mV $_{pp}$ to 2.5 V $_{pp}$ into 50 Ω

Arbitrary

Memory depth 1 to 128 k

 ${\color{red}\textbf{Amplitude range}} \qquad \qquad 20~\text{mV}_{pp}~\text{to}~5~\text{V}_{pp}~\text{into Hi-Z}$

10 mV $_{pp}$ to 2.5 V $_{pp}$ into 50 Ω

Repetition rate 0.1 Hz to 25 MHz

Sample rate 250 MS/s

Signal amplitude accuracy ±[(1.5% of peak-to-peak amplitude setting) + (1.5% of absolute DC offset setting) + 1 mV] (frequency = 1 kHz)

Signal amplitude resolution 1 mV (Hi-Z)

500 μV (50 Ω)



Datasheet

Arbitrary-Function Generator optional

Sine and ramp frequency accuracy	130 ppm (frequency ≤10 kHz)
	50 ppm (frequency >10 kHz)
DC offset range	±2.5 V into Hi-Z
	±1.25 V into 50 Ω
DC offset resolution	1 mV (Hi-Z)
	500 μV (50 Ω)
DC offset accuracy	±[(1.5% of absolute offset voltage setting) + 1 mV]
	Add 3 mV of uncertainty per 10 °C change from 25 °C ambient

Digital volt meter (DVM)

Measurement types	DC, AC _{RMS} +DC, AC _{RMS} , Trigger frequency count
Voltage resolution	4 digits
Voltage accuracy	
DC:	$\pm((1.5\% * reading - offset - position) + (0.5\% * (offset - position)) + (0.1 * Volts/div))$
	De-rated at 0.100%/°C of reading - offset - position above 30 °C
	Signal ± 5 divisions from screen center
AC:	± 3% (40 Hz to 1 kHz) with no harmonic content outside 40 Hz to 1 kHz
	AC, typical: ± 2% (20 Hz to 10 kHz)
	For AC measurements, the input channel vertical settings must allow the V_{PP} input signal to cover between 4 and 10 divisions and must be fully visible on the screen

Trigger frequency counter

Resolution	8-digits
Accuracy	\pm (1 count + time base accuracy * input frequency) The signal must be at least 8 mV _{pp} or 2 div, whichever is greater.
Maximum input frequency	10 Hz to maximum bandwidth of the analog channel The signal must be at least 8 mV _{pp} or 2 div, whichever is greater.

Processor system

Host processor	Intel i5-4400E, 2.7 GHz, 64-bit, dual core processor
Internal storage	≥ 80 GB. Form factor is an 80 mm m.2 card with a SATA-3 interface
	512 GB m.2 drive with a SATA-3 interface (with option 6-WINM2)
Operating system	Closed Embedded OS (std configuration). No access to OS file system.
	Instrument with option 6-WINM2 installed: Microsoft Windows 10.



Input-Output ports

A 20-pin DisplayPort connector; connect to show the oscilloscop	e display on an external monitor or projector
A 29-pin DVI-I connector; connect to show the oscilloscope disp	lay on an external monitor or projector
DB-15 female connector; connect to show the oscilloscope displ	ay on an external monitor or projector
Connectors are located on the lower front right of the instrument	
0 to 2.5 V	
1 kHz	
1 kΩ	
The time-base system can phase lock to an external 10 MHz reference signal .	
There are two ranges for the reference clock.	
The instrument can accept a high-accuracy reference clock of 10 ±1 kppm.	0 MHz ±2 ppm or a lower-accuracy reference clock of 10 MHz
rts) Front panel USB Host ports: Two USB 2.0 Hi-Speed ports, one USB 3.0 SuperSpeed port	
Rear panel USB Host ports: Two USB 2.0 Hi-Speed ports, two	JSB 3.0 SuperSpeed ports
Rear panel USB Device port: One USB 3.0 SuperSpeed Device speeds	port providing USBTMC support and up to 800 Mbps transfer
10/100/1000 Mb/s	
Rear-panel BNC connector. Output can be configured to provide a positive or negative pulse out when the oscilloscope triggers, the internal oscilloscope reference clock out, or an AFG sync pulse	
Characteristic	Limits
Vout (HI)	≥ 2.5 V open circuit; ≥ 1.0 V into a 50 Ω load to ground
Vout (LO)	\leq 0.7 V into a load of \leq 4 mA; \leq 0.25 V into a 50 Ω load to ground
Rear-panel security slot connects to standard Kensington-style lock	
Class: LXI 2016	
Version: 1.5	
	A 29-pin DVI-I connector; connect to show the oscilloscope displementation of the connector are located on the lower front right of the instrument 0 to 2.5 V 1 kHz 1 kΩ The time-base system can phase lock to an external 10 MHz reference are two ranges for the reference clock. The instrument can accept a high-accuracy reference clock of 10 ±1 kppm. Front panel USB Host ports: Two USB 2.0 Hi-Speed ports, one Rear panel USB Host ports: Two USB 2.0 Hi-Speed ports, two USB 2.0 Hi-Speed Device speeds 10/100/1000 Mb/s Rear-panel BNC connector. Output can be configured to provide the internal oscilloscope reference clock out, or an AFG sync put Characteristic Vout (HI) Vout (LO) Rear-panel security slot connects to standard Kensington-style I

Power source

Power

Power consumption 360 Watts maximum

Source voltage 100 - 240 V ±10% at 50 Hz to 60 Hz

115 V \pm 10% at 400 Hz



Datasheet

Physical characteristics

Dimensions Height: 3.44 in (87.3 mm)

Width: 17.01 in (432 mm)

Depth: 23.85 in (605.7 mm)

Fits rack depths from 24 inches to 32 inches

Weight 29.4 lbs (13.34 kg)

Cooling The clearance requirement for adequate cooling is 2.0 in (50.8 mm) on the left and right sides of the instrument. Air flows from left

to right through the instrument.

Rackmount configuration 2U rack mount kit is included as standard configuration

Environmental specifications

Temperature

Operating +0 °C to +50 °C (32 °F to 122 °F) Non-operating -20 °C to +60 °C (-4 °F to 140 °F)

Humidity

Operating 5% to 90% relative humidity (% RH) at up to +40 °C

5% to RH above +40 °C up to +50 °C, noncondensing

Non-operating 5% to 90% relative humidity (% RH) at up to +60 °C, noncondensing

Altitude

Operating Up to 3,000 meters (9,843 feet)

Non-operating Up to 12,000 meters (39,370 feet)

EMC Environmental and Safety

Regulatory CE marked for the European Union and CSA approved for the USA and Canada

RoHS compliant

Software

Software

IVI driver Provides a standard instrument programming interface for common applications such as LabVIEW, LabWindows/CVI,

Microsoft .NET, and MATLAB. Compatible with Python, C/C++/C# and many other languages through VISA.

e*Scope® Enables control of the oscilloscope over a network connection through a standard web browser. Simply enter the IP address or

network name of the oscilloscope and a web page will be served to the browser. Transfer and save settings, waveforms, measurements, and screen images or make live control changes to settings on the oscilloscope directly from the web browser.

LXI Web interface Connect to the oscilloscope through a standard Web browser by simply entering the oscilloscope's IP address or network name in

the address bar of the browser. The web interface enables viewing of instrument status and configuration, status and modification of network settings, and instrument control through the e*Scope web-based remote control. All web interaction conforms to LXI

specification, version 1.5.

Programming Examples Programming with the 5 & 6 Series platforms has never been easier. With a programmers manual and a GitHub site you have

many commands and examples to help you get started remotely automating your instrument. See https://github.com/tektronix/

Programmatic-Control-Examples.



Ordering Information

Use the following steps to select the appropriate instrument and options for your measurement needs.

Step 1

Start by selecting the model.

Model	Number of channels
LPD64	4

Each model includes Rackmount attachments installed Installation and safety manual (translated in English, French, German) Embedded Help Power cord Calibration certificate documenting traceability to National Metrology Institute(s) and ISO9001/ISO17025 quality system registration One-year warranty covering all parts and labor on the instrument.

Step 2

Configure your Low Profile Digitizer by selecting the analog channel bandwidth you need Choose the bandwidth you need today by choosing one of these bandwidth options. You can upgrade it later by purchasing an upgrade option.

Bandwidth Option	Bandwidth
6-BW-1000	1 GHz
6-BW-2500	2.5 GHz
6-BW-4000	4 GHz
6-BW-6000	6 GHz
6-BW-8000	8 GHz



Step 3

Add instrument functionality

Instrument functionality can be ordered with the instrument or later as an upgrade kit.

Instrument Option	Built-in Functionality
6-RL-2	Extend record length from 125 Mpoints/channel to 250 Mpoints/channel
6-AFG	Add Arbitrary / Function Generator
6-SEC ^{3 4}	Security package adds enhanced security that restricts user data from being saved to the instrument, password-protected enabling for USB ports and firmware updates. Recommended for highly classified data environments.
6-WINM2 ⁴	Instrument replaces std. embedded linux OS with Windows 10 Operating system on a m.2 512GB drive.

Step 4

Add optional serial bus triggering, decode, and search capabilities

Choose the serial support you need today by choosing from these serial analysis options. You can upgrade later by purchasing an upgrade kit.

Instrument Option	Serial Buses Supported
6-SRAERO	Aerospace (MIL-STD-1553, ARINC 429)
6-SRAUDIO	Audio (I ² S, LJ, RJ, TDM)
6-SRAUTO	Automotive (CAN, CAN FD, LIN, FlexRay, and CAN symbolic decoding)
6-SRAUTOEN1	100BASE-T1 Automotive Ethernet serial analysis
6-SRAUTOSEN	Automotive sensor (SENT)
6-SRCOMP	Computer (RS-232/422/485/UART)
6-SREMBD	Embedded (I ² C, SPI)
6-SRENET	Ethernet (10BASE-T, 100BASE-TX)
6-SR8B10B	8B/10B (decode and search only)
6-SRI3C	MIPI I3C (I3C decode and search only)
6-SRNRZ	NRZ (decode and search only)
6-SRPM	Power Management (SPMI)
6-SRPSI5	PSI5 (decode and search only)
6-SRSPACEWIRE	Spacewire (decode and search only)
6-SRUSB2	USB (USB2.0 LS, FS, HS)

⁴ This option must be purchased at the same time as the instrument. Not available as an upgrade.



³ This option is not compatible with option 6-WINM2.

Step 5

Add optional serial bus compliance testing

Choose the serial compliance testing packages you need today by choosing from these options. You can upgrade later by purchasing an upgrade kit. All options in the table below require option 6-WIN (SSD with Microsoft Windows 10 operating system).

Instrument Option	Serial Buses Supported
6-CMNBASET	2.5 and 5 GBASE-T Ethernet automated compliance test solution. 2.5 GHz is recommended

Step 6

Add optional memory analysis

Instrument Option	Advanced Analysis
6-DBDDR3	DDR3 and LPDDR3 Debug and Analysis

Step 7

Add optional analysis capabilities

Instrument Option	Advanced Analysis		
6-DBLVDS	TekExpress automated LVDS test solution (requires option 6-DJA)		
6-DJA	Advanced Jitter and Eye Analysis		
6-DPM	Digital Power Management		
6-MTM	Mask and Limit testing		
6-PAM3	PAM3 Analysis (requires options 6-DJA and 6-WIN)		
6-PWR	Power Measurement and Analysis		
6-SV-BW-1	Increase Spectrum View Capture Bandwidth to 2 GHz		
6-SV-RFVT	Spectrum View RF versus Time Analysis and remote IQ data transferring		
6-VID	NTSC, PAL, and SECAM video triggering		

Step 8

Add accessories

Optional Accessory	Description	
020-3180-xx	Benchtop conversion kit including four (4) instrument feet and a strap handle	
016-2139-xx	Hard transit case with handles and wheels for easy transportation	
003-1929-xx	SMA 8-lb Torque Wrench for connecting SMA cables	
174-6211-xx	2x Matched SMA cables (within 1 pS)	
174-6212-xx	4x Matched SMA cables (within 1 pS)	
174-6215-00	Power Divider, 2-way, 50 Ohm, DC-18 GHz	
174-6214-00	Power Divider, 4-way, 50 Ohm, DC-18 GHz	
GPIB to Ethernet adapter	Order model 4865B (GPIB to Ethernet to Instrument Interface) directly from ICS Electronics www.icselect.com/gpib_instrument_intfc.html	



Step 9

Select power cord option

Power Cord Option	Description		
A0	North America power plug (115 V, 60 Hz) Includes mechanism that retains power cord to instrument		
A1	Universal Euro power plug (220 V, 50 Hz)		
A2	United Kingdom power plug (240 V, 50 Hz)		
A3	Australia power plug (240 V, 50 Hz)		
A5	Switzerland power plug (220 V, 50 Hz)		
A6	Japan power plug (100 V, 50/60 Hz)		
A10	China power plug (50 Hz)		
A11	India power plug (50 Hz)		
A12	Brazil power plug (60 Hz)		
A99	No power cord		

Step 10

Add extended service and calibration options

Service Option	Description	
G3	Three Year Gold Care Plan. Includes expedited repair of all product failures including ESD and EOS, access to a loaner product during repair or advanced exchange to reduce downtime, priority access to Customer Support among others.	
G5	Five Year Gold Care Plan. Includes expedited repair of all product failures including ESD and EOS, access to a loaner product during repair or advanced exchange to reduce downtime, priority access to Customer Support among others.	
R3	Standard Warranty Extended to 3 Years. Covers parts, labor and 2-day shipping within country. Guarantees faster repair time than without coverage. All repairs include calibration and updates. Hassle free - a single call starts the process.	
R5	Standard Warranty Extended to 5 Years. Covers parts, labor and 2-day shipping within country. Guarantees faster repair time than without coverage. All repairs include calibration and updates. Hassle free - a single call starts the process.	
С3	Calibration service 3 Years. Includes traceable calibration or functional verification where applicable, for recommended calibrations. Coverage includes the initial calibration plus 2 years calibration coverage.	
C5	Calibration service 5 Years. Includes traceable calibration or functional verification where applicable, for recommended calibrations. Coverage includes the initial calibration plus 4 years calibration coverage.	
D1	Calibration Data Report	
D3	Calibration Data Report 3 Years (with Option C3)	
D5	Calibration Data Report 5 Years (with Option C5)	



Feature upgrades after purchase

Add feature upgrades in the future The 6 Series products offer many ways to easily add functionality after the initial purchase. Node-locked licenses permanently enable optional features on a single product. Floating licenses allow license-enabled options to be easily moved between compatible instruments.

Upgrade feature	Node-locked license upgrade	Floating license upgrade	Description
Add instrument functions	SUP6-AFG	SUP6-AFG-FL	Add arbitrary function generator
	SUP6-RL-2	SUP6-RL-2-FL	Extend record length to 250 Mpts / channel
Add protocol analysis	SUP6-SRAERO	SUP6-SRAERO-FL	Aerospace serial triggering and analysis (MIL-STD-1553, ARINC 429)
	SUP6-SRAUDIO	SUP6-SRAUDIO-FL	Audio serial triggering and analysis (I ² S, LJ, RJ, TDM)
	SUP6-SRAUTO	SUP6-SRAUTO-FL	Automotive serial triggering and analysis (CAN, CAN FD, LIN, FlexRay, and CAN symbolic decoding)
	SUP6-SRAUTOEN1	SUP6-SRAUTOEN1-FL	100Base-T1 Automotive Ethernet serial analysis
	SUP6-SRAUTOSEN	SUP6-SRAUTOSEN-FL	Automotive sensor serial triggering and analysis (SENT)
	SUP6-SRCOMP	SUP6-SRCOMP-FL	Computer serial triggering and analysis (RS-232/422/485/UART)
	SUP6-SREMBD	SUP6-SREMBD-FL	Embedded serial triggering and analysis (I ² C, SPI)
	SUP6-SRENET	SUP6-SRENET-FL	Ethernet serial triggering and analysis (10Base-T, 100Base-TX)
	SUP6-SRI3C	SUP6-SRI3C-FL	MIPI I3C serial decoding and analysis
	SUP6-SR8B10B	SUP6-SR8B10B-FL	8b/10b serial decoding and analysis
	SUP6-SRNRZ	SUP6-SRNRZ-FL	NRZ serial decoding and analysis
	SUP6-SRPM	SUP6-SRPM-FL	Power Management serial triggering and analysis (SPMI)
	SUP6-SRPSI5	SUP6-SRPSI5-FL	PSI5 serial decoding and analysis
	SUP6-SRSPACEWIRE	SUP6-SRSPACEWIRE- FL	Spacewire (decode and search only)
	SUP6-SRUSB2	SUP6-SRUSB2-FL	USB 2.0 serial bus triggering and analysis (LS, FS, HS)
Add serial compliance All serial compliance products require option 6-WINM2 (Microsoft Windows 10 operating system)	SUP6-CMNBASET	SUP6-CMNBASET-FL	Ethernet automated compliance test solution.
Add advanced analysis	SUP6-DBLVDS	SUP6-DBLVDS-FL	LVDS debug and analysis (requires option 6-DJA and 6-WINM2)
	SUP6-DJA	SUP6-DJA-FL	Advanced jitter and eye analysis
	SUP6-PWR	SUP6-PWR-FL	Advanced power measurements and analysis
	SUP6-DPM	SUP6-DPM-FL	Digital power management
	SUP6-SV-RFVT	SUP6-SV-RFVT-FL	Spectrum View RF versus time analysis
	SUP6-SV-BW-1	SUP6-SV-BW-1-FL	Increase Spectrum View capture bandwidth to 2 GHz
	SUP6-PAM3	SUP6-PAM3-FL	PAM3 analysis (requires option 6-DJA)



Upgrade feature	Node-locked license upgrade	Floating license upgrade	Description
Add memory analysis	SUP6-DBDDR3	SUP6-DBDDR3-FL	DDR3 and LPDDR3 debug and analysis
Add digital voltmeter	SUP6-DVM	N/A	Add digital voltmeter / trigger frequency counter (Free with product registration at www.tek.com/ register6mso)

Bandwidth upgrades after purchase

Add bandwidth upgrades in the future

The analog bandwidth of 6 Series Low Profile Digitizer products can be upgraded after initial purchase. Bandwidth upgrades are purchased based on the current bandwidth and the desired bandwidth. All bandwidth upgrades can be performed in the field by installing a software license and a new front panel label.

Model to be upgraded	Bandwidth before upgrade	Bandwidth after upgrade	Order this bandwidth upgrade
LPD64	1 GHz	2.5 GHz	SUP6LP-BW10T254
	1 GHz	4 GHz	SUP6LP-BW10T404
	1 GHz	6 GHz	SUP6LP-BW10T604
	1 GHz	8 GHz	SUP6LP-BW10T804
	2.5 GHz	4 GHz	SUP6LP-BW25T404
	2.5 GHz	6 GHz	SUP6LP-BW25T604
	2.5 GHz	8 GHz	SUP6LP-BW25T804
	4 GHz	6 GHz	SUP6LP-BW40T604
	4 GHz	8 GHz	SUP6LP-BW40T804
	6 GHz	8 GHz	SUP6LP-BW60T804





Tektronix is registered to ISO 9001 and ISO 14001 by SRI Quality System Registrar.



 $Product(s)\ complies\ with\ IEEE\ Standard\ 488.1-1987,\ RS-232-C,\ and\ with\ Tektronix\ Standard\ Codes\ and\ Formats.$



Product Area Assessed: The planning, design/development and manufacture of electronic Test and Measurement instruments.





ASEAN / Australasia (65) 6356 3900 Belgium 00800 2255 4835* Central East Europe and the Baltics +41 52 675 3777 Finland +41 52 675 3777 Hong Kong 400 820 5835 Japan 81 (3) 6714 3086 Middle East, Asia, and North Africa +41 52 675 3777 People's Republic of China 400 820 5835 Republic of Korea +822 6917 5084, 822 6917 5080 Spain 00800 2255 4835*

Taiwan 886 (2) 2656 6688

Austria 00800 2255 4835* Brazil +55 (11) 3759 7627 Central Europe & Greece +41 52 675 3777 France 00800 2255 4835* India 000 800 650 1835 Luxembourg +41 52 675 3777 The Netherlands 00800 2255 4835* Poland +41 52 675 3777 Russia & CIS +7 (495) 6647564 Sweden 00800 2255 4835* United Kingdom & Ireland 00800 2255 4835* Balkans, Israel, South Africa and other ISE Countries +41 52 675 3777 Canada 1 800 833 9200 Denmark +45 80 88 1401 Germany 00800 2255 4835* Italy 00800 2255 4835* Mexico, Central/South America & Caribbean 52 (55) 56 04 50 90 Norway 800 16098

Portugal 80 08 12370 South Africa +41 52 675 3777 Switzerland 00800 2255 4835* USA 1 800 833 9200

* European toll-free number. If not accessible, call: +41 52 675 3777

For Further Information. Tektronix maintains a comprehensive, constantly expanding collection of application notes, technical briefs and other resources to help engineers working on the cutting edge of technology. Please visit www.tek.com.

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서울본사 서울특별시 영등포구 경인로 775(문래동 3가, 에이스하이테크시티 3동 2층 201호)

TEL: 070-7872-0701 FAX: 02-2167-3801 E-mail: sales@nubicom.co.kr

대전지사 대전광역시 유성구 덕명동로 22번길 10

TEL: 070-7872-0712 FAX: 02-2167-3801

E-mail: jbkim@nubicom.co.kr